Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/623,692	TAKEUCHI ET AL.	
Examiner	Art Unit	
James Phan	2872	

	SEAR	CHED	
Class	Subclass	Date	Examiner
359	205- 207	9/05	1.1-
	216		
347	258 -		
	258 - 261		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST see attachments	9/05	۲۰۲۰		